



DMG4932LSD

ASYMETRICAL DUAL N-CHANNEL ENHANCEMENT MODE MOSFET

Features

- High Density UMOS with Schottky Barrier Diode
- Low Leakage Current at High Temp.
- High Conversion Efficiency
- Low On-Resistance
- Low Input Capacitance
- Fast Switching Speed
- Utilizes Diodes' Monolithic DIOFET Technology to Increase Conversion Efficiency
- 100% UIS and R_q Tested
- Lead Free By Design/RoHS Compliant (Note 1)
- "Green" Device (Note 2)
- Qualified to AEC-Q101 Standards for High Reliability

Mechanical Data

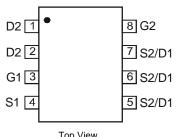
- Case: SO-8
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram Below
- Marking Information: See Page 8
- Ordering Information: See Page 8
- Weight: 0.072 grams (approximate)



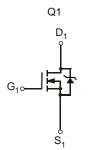
Diodes Schottky Integrated MOSFET



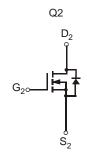
Top View



Top View Internal Schematic



N-Channel MOSFET



N-Channel MOSFET

Maximum Ratings - Q1 @TA = 25°C unless otherwise specified

Chara	Symbol	Value	Unit		
Drain-Source Voltage			V_{DSS}	30	V
Gate-Source Voltage			V _{GSS}	±12	V
Continuous Drain Current (Note 3)	Steady State	T _A = 25°C T _A = 85°C	I _D	9.5 7.2	А
Pulsed Drain Current (Note 4)	I _{DM}	40	А		
Avalanche Current (Notes 4 & 5)			I _{AR}	13	Α
Repetitive Avalanche Energy (Notes 4 & 5) L = 0.3mH			E _{AR}	25.4	mJ

Maximum Ratings - Q2 @TA = 25°C unless otherwise specified

Char	Symbol	Value	Unit		
Drain-Source Voltage			V _{DSS}	30	V
Gate-Source Voltage			V _{GSS}	±25	V
Continuous Drain Current (Note 3)	Steady State	T _A = 25°C T _A = 85°C	I _D	9.5 7.5	А
Pulsed Drain Current (Note 4)			I _{DM}	40	Α
Avalanche Current (Notes 4 & 5)			I _{AR}	13	Α
Repetitive Avalanche Energy (Notes 4 & 5) L = 0.3mH			E _{AR}	25.4	mJ

Thermal Characteristics

Characteristic	Symbol	Value	Unit
Power Dissipation (Note 3)	P _D	1.19	W
Thermal Resistance, Junction to Ambient @T _A = 25°C (Note 3)	$R_{\theta JA}$	107	°C/W
Operating and Storage Temperature Range	T _J , T _{STG}	-55 to +150	°C

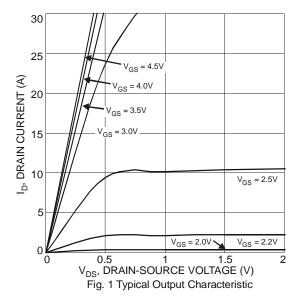
Notes:

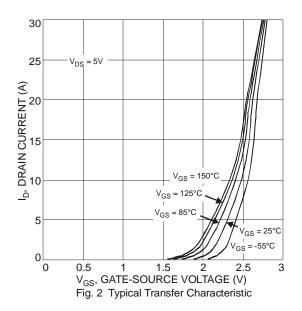
- 1. No purposefully added lead.
- 2. Diodes Inc.'s "Green" policy can be found on our website at http://www.diodes.com/products/lead_free/index.php.
- 3. Device mounted on FR-4 PCB with minimum recommended pad layout. The value in any given application depends on the user's specific board design.
- 4. Repetitive rating, pulse width limited by junction temperature.
- 5. I_{AR} and E_{AR} rating are based on low frequency and duty cycles to keep $T_J = 25^{\circ}C$



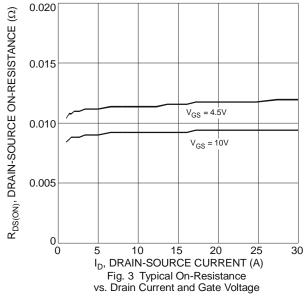
Electrical Characteristics - Q1 @TA = 25°C unless otherwise specified

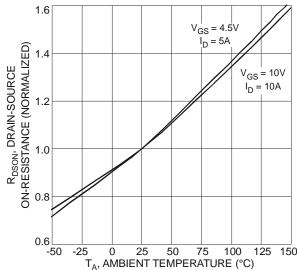
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 6)							
Drain-Source Breakdown Voltage	BV _{DSS}	30	-	-	V	$V_{GS} = 0V$, $I_D = 1mA$	
Zero Gate Voltage Drain Current	I _{DSS}	-	-	0.1	mA	$V_{DS} = 30V, V_{GS} = 0V$	
Gate-Source Leakage	I _{GSS}	-	-	±100	nA	$V_{GS} = \pm 12V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 6)							
Gate Threshold Voltage	$V_{GS(th)}$	1.0	-	2.4	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	
Static Drain-Source On-Resistance			10	15	mΩ	$V_{GS} = 10V, I_D = 9A$	
Static Drain-Source On-Resistance	R _{DS (ON)}	-	12	18	111 \(\(\) 2	$V_{GS} = 4.5V, I_D = 7A$	
Forward Transfer Admittance	Y _{fs}	-	14	-	S	$V_{DS} = 10V, I_{D} = 9A$	
Diode Forward Voltage	V_{SD}	-	0.4	0.6	V	$V_{GS} = 0V, I_{S} = 1A$	
Maximum Body-Diode + Schottky Continuous Current	Is	-	-	5	Α	-	
DYNAMIC CHARACTERISTICS (Note 7)							
Input Capacitance	C _{iss}	-	1932	-	pF		
Output Capacitance	Coss	-	154	-	pF	$V_{DS} = 15V, V_{GS} = 0V, f = 1.0MHz$	
Reverse Transfer Capacitance	C _{rss}	-	121	-	pF		
Gate Resistance	Rg	-	2.68	-	Ω	$V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1MHz$	
Total Gate Charge (4.5V)	Qg	-	18.1	-	nC		
Total Gate Charge (10V)	Qg	-	42.0	-	nC	15// 15// 10// 10//	
Gate-Source Charge	Q_{gs}	-	4.5	-	nC	$V_{DS} = 15V, V_{GS} = 10V, I_{D} = 9A$	
Gate-Drain Charge	Q _{qd}	-	4.0	-	nC	1	
Turn-On Delay Time	t _{D(on)}	-	6.16	-	ns		
Turn-On Rise Time	t _r	-	7.22	-	ns	$V_{GS} = 10V, V_{DS} = 15V,$ $R_G = 3\Omega, R_L = 1.7\Omega$	
Turn-Off Delay Time	t _{D(off)}	-	36.76	-	ns		
Turn-Off Fall Time	t _f	-	5.38	-	ns		

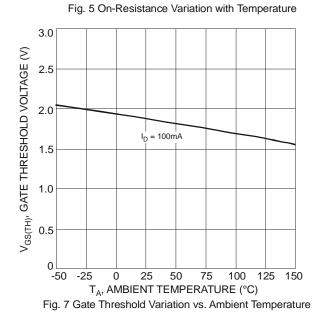


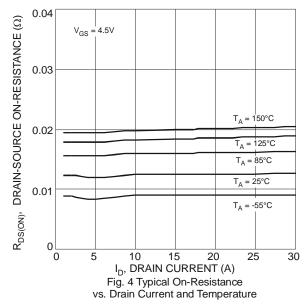












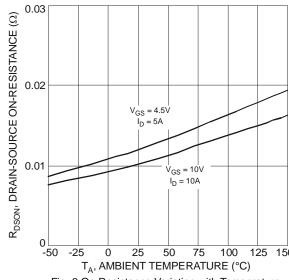


Fig. 6 On-Resistance Variation with Temperature

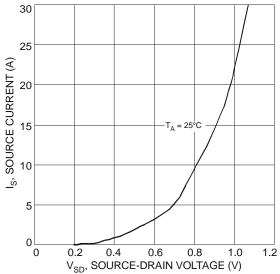
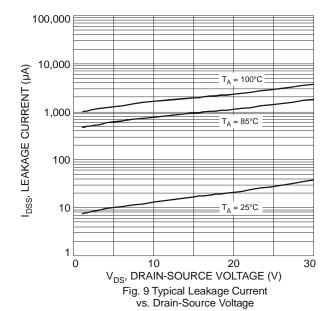
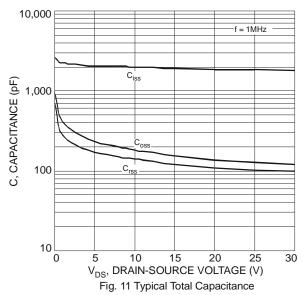
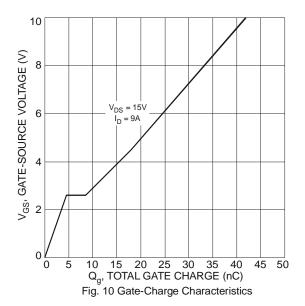


Fig. 8 Diode Forward Voltage vs. Current









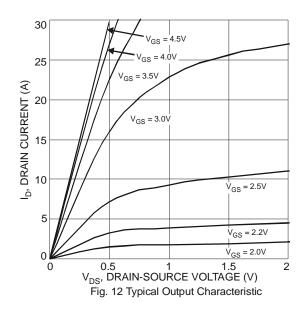


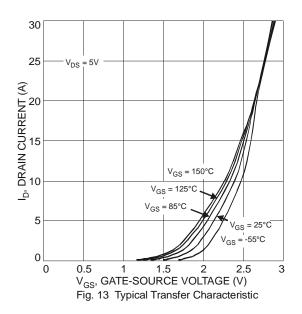
Electrical Characteristics – Q2 @TA = 25°C unless otherwise specified

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
DFF CHARACTERISTICS (Note 6)							
Drain-Source Breakdown Voltage	BV _{DSS}	30	-	-	V	$V_{GS} = 0V, I_D = 250\mu A$	
Zero Gate Voltage Drain Current	I _{DSS}	-	-	1	μΑ	$V_{DS} = 30V, V_{GS} = 0V$	
Coto Source Leakage		-	-	+100	nA	$V_{GS} = +25V, V_{DS} = 0V$	
Gate-Source Leakage	I _{GSS}	-	-	-800	IIA	$V_{GS} = -25V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 6)							
Gate Threshold Voltage	$V_{GS(th)}$	1.0	-	2.3	V	$V_{DS} = V_{GS}, I_D = 250 \mu A$	
Static Drain-Source On-Resistance			12	15.8	mΩ	$V_{GS} = 10V, I_D = 9A$	
Static Drain-Source On-Resistance	R _{DS} (ON)	-	16	23	111 \(\)2	$V_{GS} = 4.5V, I_D = 7A$	
Forward Transfer Admittance	Y _{fs}	-	8	-	S	$V_{DS} = 10V, I_{D} = 9A$	
Diode Forward Voltage	V_{SD}	-	0.65	1.0	V	$V_{GS} = 0V, I_{S} = 1A$	
DYNAMIC CHARACTERISTICS (Note 7)							
Input Capacitance	C _{iss}	-	675	-	pF	\\ 45\\\\\ 0\\	
Output Capacitance	Coss	-	98	-	pF	$V_{DS} = 15V, V_{GS} = 0V,$ of = 1.0MHz	
Reverse Transfer Capacitance	C _{rss}	-	90	-	pF	1 = 1:01/11/12	
Gate Resistance	Rg	-	1.6	-	Ω	$V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1MHz$	
Total Gate Charge (4.5V)	Q_g	-	7.8	-	nC		
Total Gate Charge (10V)	Qg	-	16.0	-	nC	$V_{DS} = 15V, V_{GS} = 10V, I_{D} = 9A$	
Gate-Source Charge	Qgs	-	1.9	-	nC	1	
Gate-Drain Charge	Q_{gd}	-	2.6	-	nC		
Turn-On Delay Time	t _{D(on)}	-	5.05	-	ns		
Turn-On Rise Time	t _r	-	9.21	-	ns	$V_{GS} = 10V, V_{DS} = 15V,$	
Turn-Off Delay Time	t _{D(off)}	-	20.76	-	ns	$R_G = 3\Omega$, $R_L = 1.7\Omega$	
Turn-Off Fall Time	t _f	-	4.94	-	ns	1	

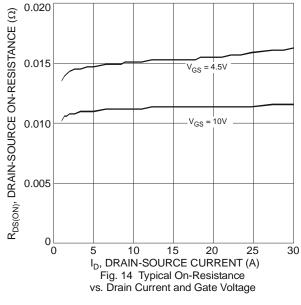
Notes:

- 6. Short duration pulse test used to minimize self-heating effect.
- 7. Guaranteed by design. Not subject to production testing.









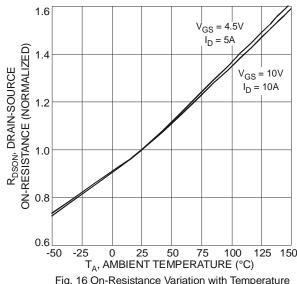


Fig. 16 On-Resistance Variation with Temperature

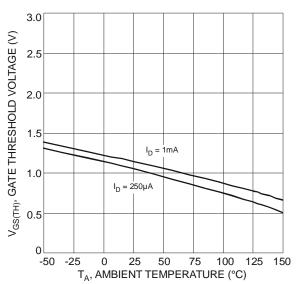
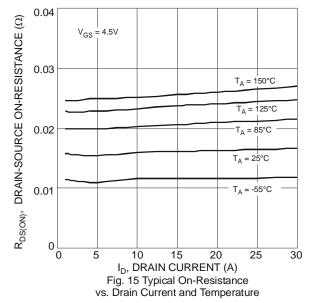


Fig. 18 Gate Threshold Variation vs. Ambient Temperature



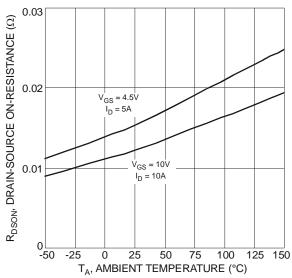
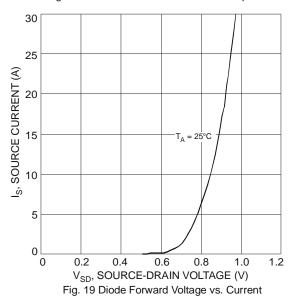
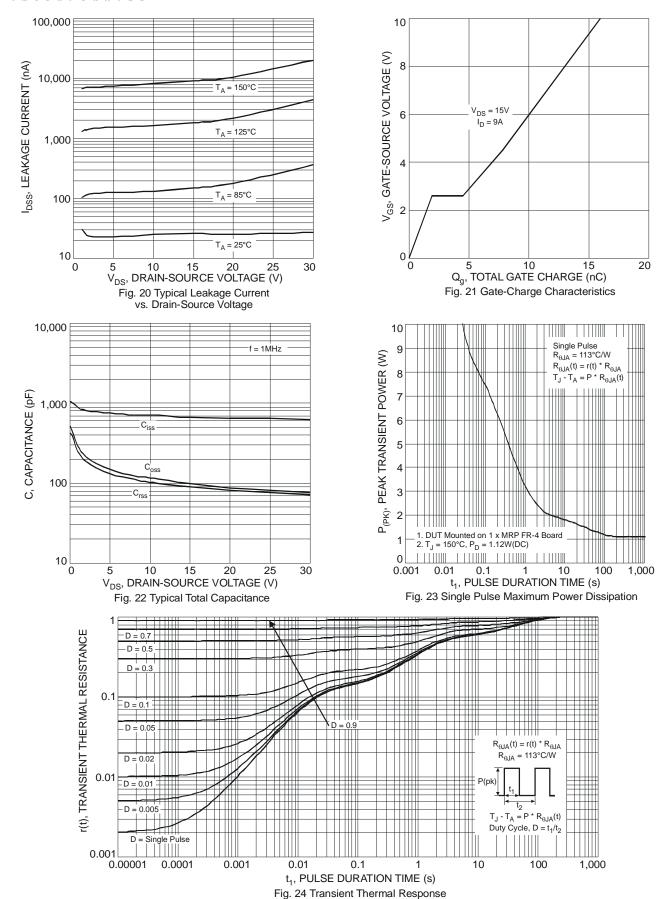


Fig. 17 On-Resistance Variation with Temperature







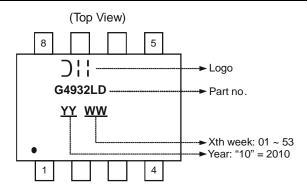


Ordering Information (Note 8)

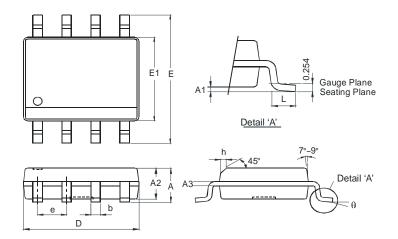
Part Number	Case	Packaging
DMG4932LSD-13	SO-8	2500 / Tape & Reel

Notes: 8. For packaging details, go to our website at http://www.diodes.com/datasheets/ap02007.pdf.

Marking Information

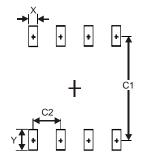


Package Outline Dimensions



SO-8					
Dim	Min	Max			
Α	ı	1.75			
A1	0.10	0.20			
A2	1.30	1.50			
A3	0.15	0.25			
b	0.3	0.5			
D	4.85	4.95			
Е	5.90	6.10			
E1	3.85	3.95			
е	e 1.27 Typ				
h	1	0.35			
L	0.62	0.82			
θ	0°	8°			
All Dimensions in mm					

Suggested Pad Layout



Dimensions	Value (in mm)
X	0.60
Υ	1.55
C1	5.4
C2	1.27



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 - 2. support or sustain life and whose failure to perform when properly used in accordance with instructions for use provided in the labeling can be reasonably expected to result in significant injury to the user.
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